

# Aspects of the photometric G band calibration and the expected photometric precision

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## Abstract

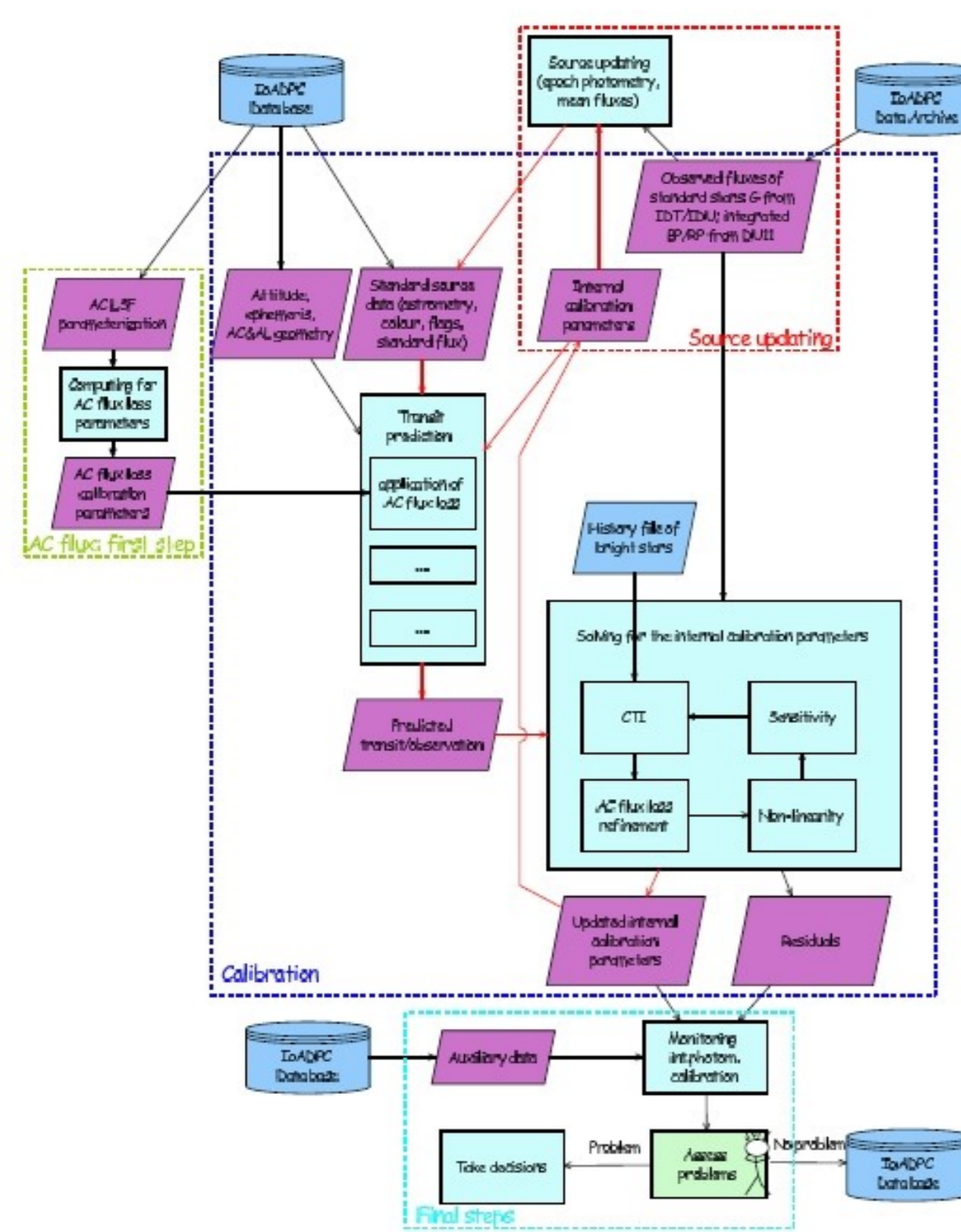
Gaia will observe about 1 billion sources at about 80 different epochs on the average providing broad-band white-light photometry (G band). The instrumental sensitivity depends on many different effects that will also change with time. The Gaia instrument is a rather complex device. Each of the 62 CCDs used for G band observations will show its own sensitivity behaviour depending on wavelength, the across scan position of the observation and time. The PSF will vary across the two FoVs. A fraction of the total flux will not be recorded due to the discrete size of the apertures. Non-linearity of the CCDs, residuals of the CTI-effects, sensitivity variations originating from the optics and the variations mentioned before have to be internally calibrated for all of the different instrument configurations (gates, 2D windows, 1D windows, ...). This internal calibration aims to transfer all the single observations by different instrumental configurations to observations as made by a mean instrument. In a second step this flux data has to be calibrated externally providing 'true' fluxes.

The CU5 group is responsible for developing and executing the rather complex calibration process for the G band photometry. The team of the University of Barcelona has investigated single effects like sensitivity variations on CCD and CCD column level, non-linearities, flux loss due to the limited sized of the extraction windows and combinations of these effects. All known effects affecting the G band observations will have to be taken into account when the tests of different calibration models are continued.

Based on the calibration tests already carried out preliminary expected errors of the photometric precision for the G band will be provided allowing a better evaluation of what kind of scientific results can be derived from Gaia G band photometry.

## Calibration Scheme

Proposed scheme of the Internal Calibration of the G band:



The aim of the internal calibration is to provide an internally consistent flux scale for the entire mission duration. As the Gaia instrument is a rather complex device with 62 CCDs in the FPA, 2 FoVs, gated and ungated observations with different window classes which will observe about 1 billion sources this is a very challenging task.

The standard principle of the calibration procedure is to derive standard fluxes from the Gaia observations themselves and take these observations in combination with the current set of calibration parameters to make a prediction of the observed fluxes to derive a new set of the internal calibration parameters. The instrumental variations can be described as small corrections to the current set of calibration parameters.

The data is assumed to be preprocessed (basic image calibration, bias and background subtracted, CTI (Charge Transfer Inefficiencies) effects estimated).

The internal calibration includes:

- > Selection of a large set of suitable reference sources (non-variable, isolated, distribution in colour, space and time)
- > Prediction of the across scan flux loss for 1D window observations based on the current PSF/LSF model
- > The iterative solution itself solves for a new set of calibration parameters based on the predicted observations and takes care of sensitivity variations of the instrument on different scales, non-linearities of the CCDs and residuals of CTI and across flux loss.
- > Monitoring of the residuals to discover any new change of the instrument which is not covered yet by the calibration model currently used.

The aim is to reach a precision of the internal calibration which is limited by the observational noise and not by the calibration noise. The calibration noise should at least be five times smaller than the observational noise.

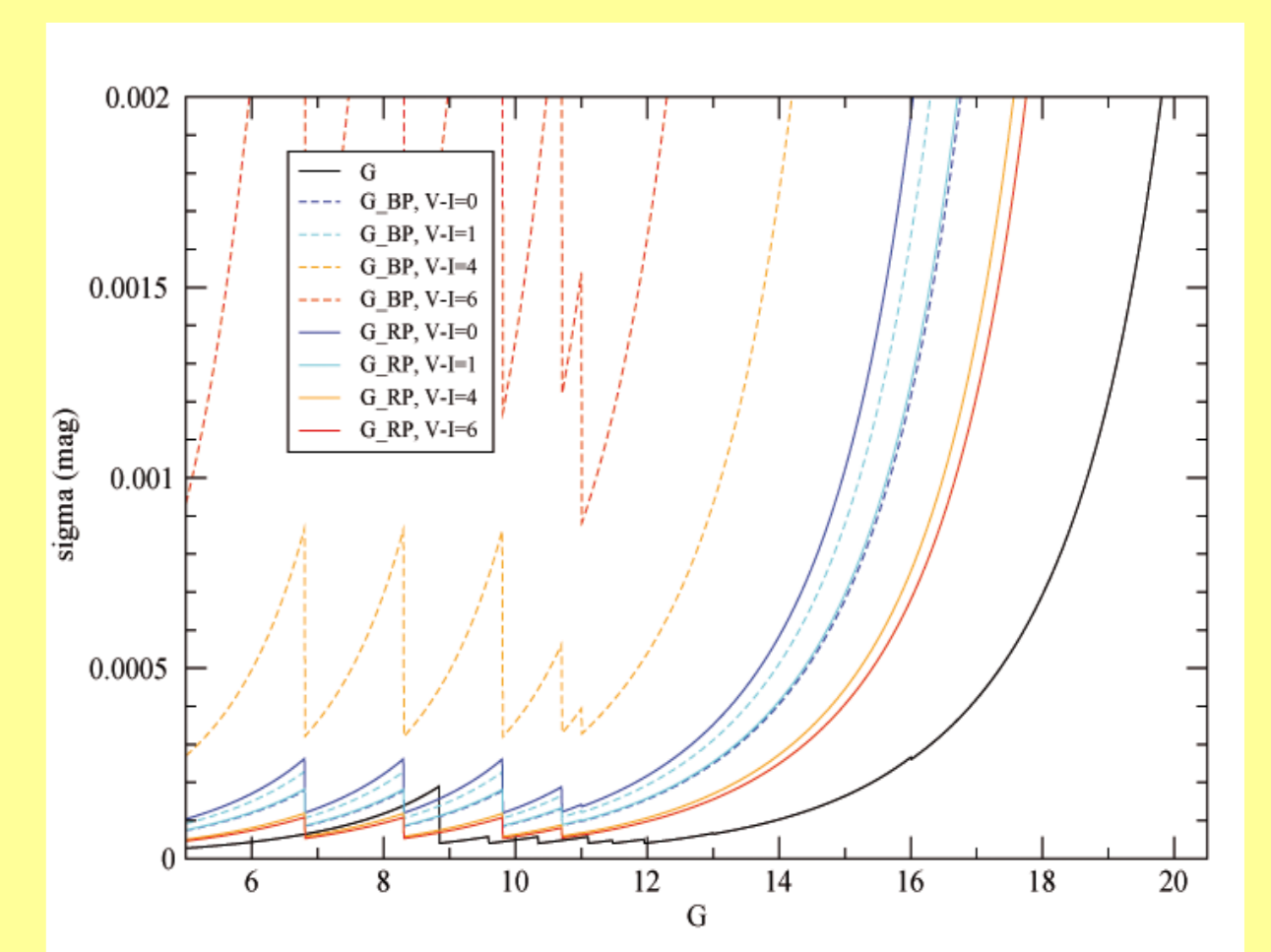
Additionally an external flux calibration has to be applied to connect the internally calibrated Gaia data with the real world comparing the fluxes of SPSS (Spectro-Photometric Standard Stars) which are observed spectrophotometrically from the ground.

## Expected photometric precision

The aim is that the total noise after internal calibration is not dominated by the calibration noise but by the observation noise. This can be achieved by setting an upper limit for the calibration noise to 20% of the observation noise. As it was shown in calibration tests the derived calibration results are still below this limit. Nevertheless, as the simulated data did not contain all known effects (e.g., CTI, non-linearities), it is still uncertain if this level of photometric precision can be really obtained for real Gaia data.

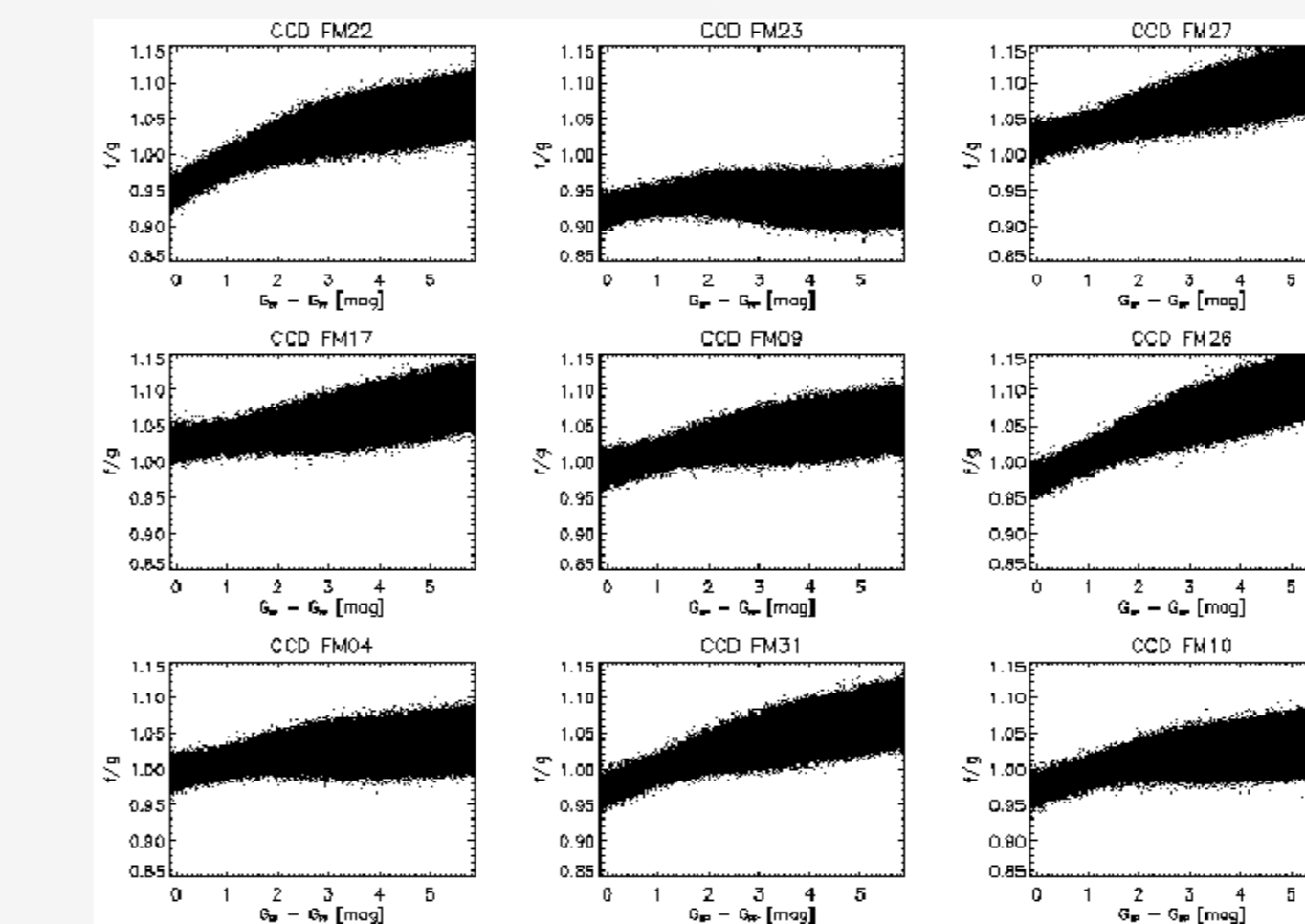
Following an aperture photometry approach the observation noise itself is computed based on the latest information about the total detection noise per pixel/sample and the sky background noise per pixel/sample. The mean number of observations is assumed to be 80. The flux lost outside the extraction window was estimated to 0.1 of the total flux. The different effective exposure times were taken into account for gated observations. 2D windows were assumed for all sources with  $G < 13$  for the G band observations. For BP and RP band observations this limit was set to  $G < 11$ . The different window classes are based on the latest information available. No saturation effects are accounted for. An extra-margin of 20% accounting for the calibration noise has been added.

From this computation, the estimated end-of-mission photometric precision is shown in the figure to the right. G and integrated  $G_{BP}$  and  $G_{RP}$  yield uncertainties at mmag level or better.

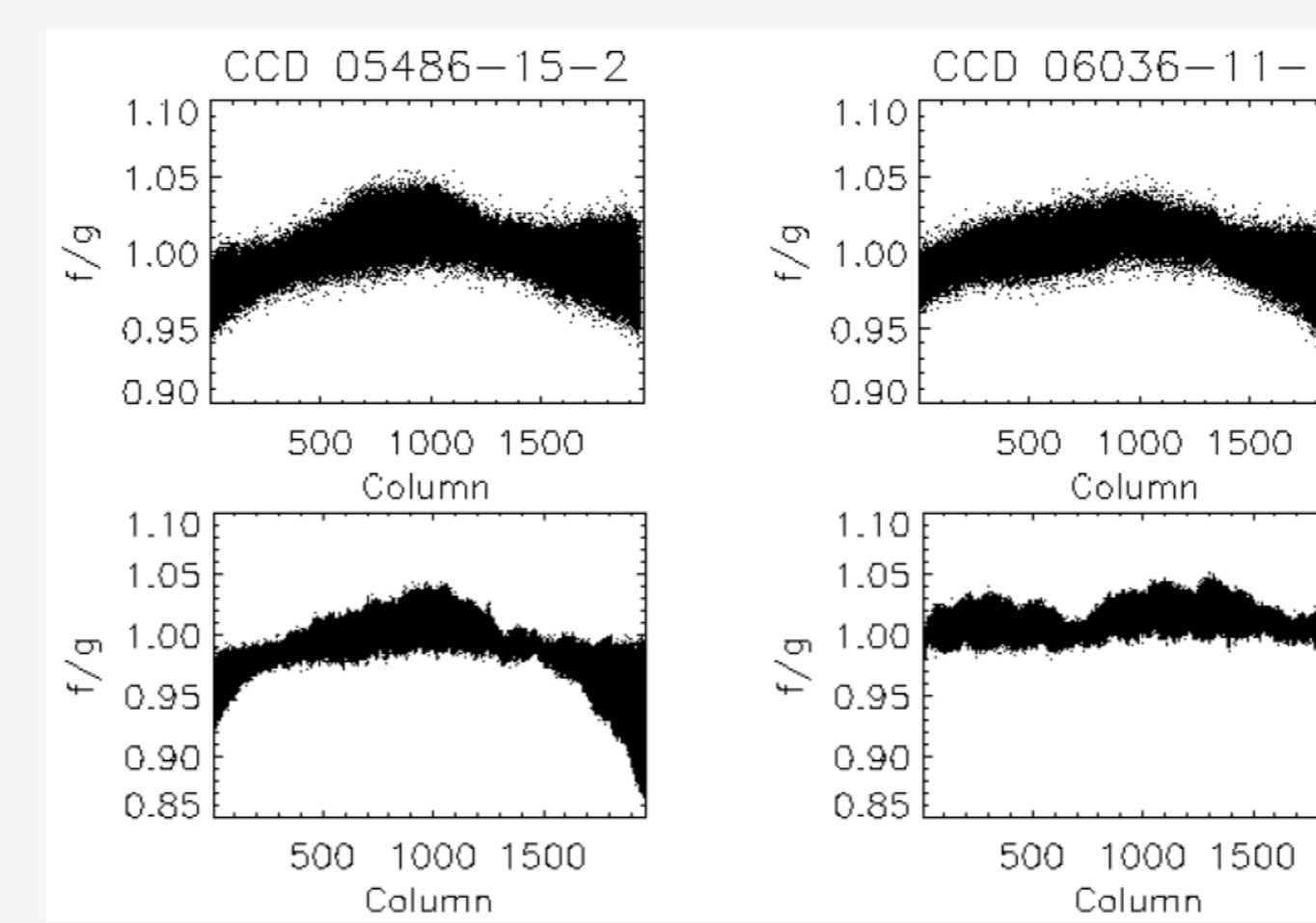


Expected end-of-mission uncertainties for G,  $G_{BP}$  and  $G_{RP}$  for sources with the colours  $V-I=0, 1, 4$  and  $6$ .  $G_{BP}$  and  $G_{RP}$  are the integrated flux of the BP and RP spectra.

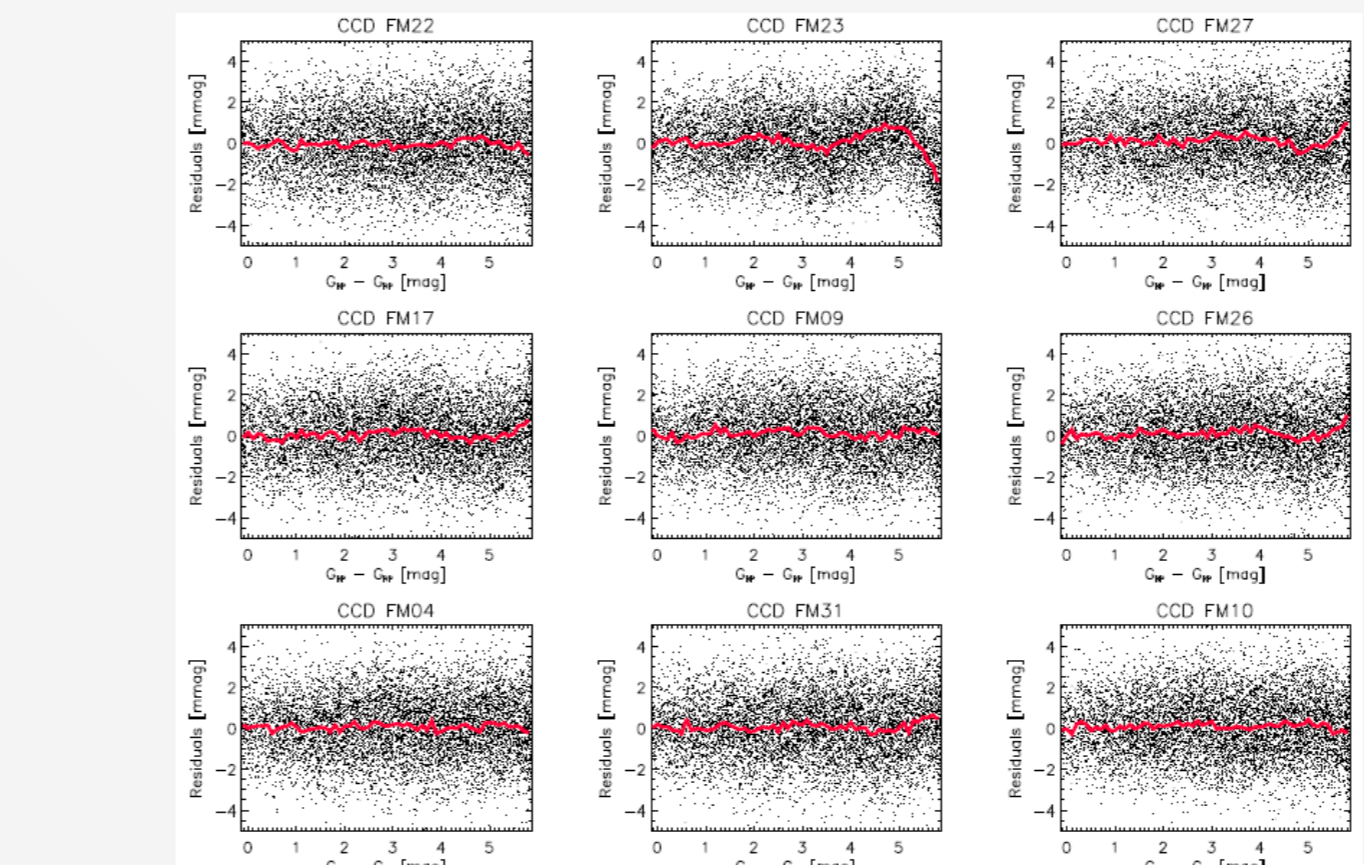
## Calibration tests with simulated data



Observed fluxes  $f$  divided by standard fluxes  $g$  of simulated data for 9 different CCDs versus colour  $G_{BP}-G_{RP}$ . Note the variations especially for very red sources.



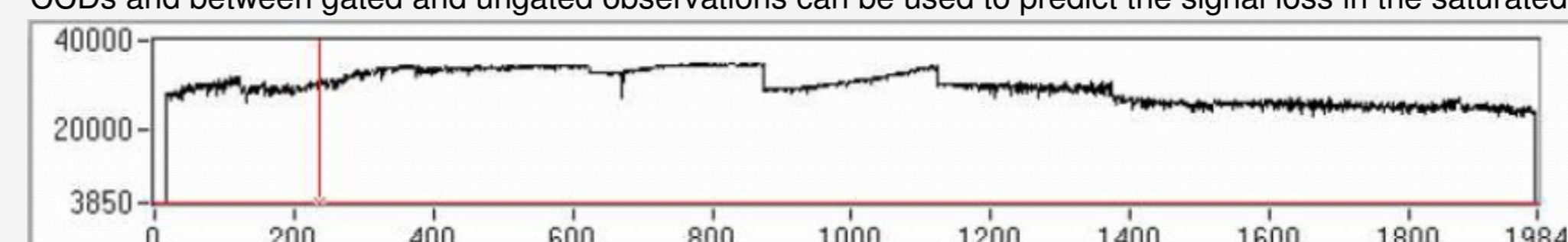
Observed fluxes  $f$  divided by standard fluxes  $g$  of simulated data for 2 different CCDs versus CCD column for 1D observations of sources  $13 < G < 17$  with nominal noise (upper part) and observations with the shortest gate #4 (low part).



Residuals of the brightest sources after the calibration for the data of the 9 simulated CCDs vs. source colour. Note the large calibration residuals of red sources for some of the CCDs. The CCD-to-CCD sensitivity variations are dominating the residuals.

## Further aspects of the internal calibration

**Saturation:** In TDI mode the saturation can appear on pixel level, on column level and on the level of the summing and readout register. A first saturation can appear when the collected charge of a source is reaching the pixel with the lowest full-well-capacity (FWC) in the column. Additional saturation can occur further in the same column as more charge can be collected. Nevertheless, it is expected that the transition from saturation to the linear response is more or less smooth, but different for each column and CCD. Thus it will happen that some sources cause saturation in only some few CCDs. Intercomparison of the fluxes between the CCDs and between gated and ungated observations can be used to predict the signal loss in the saturated observations.



Example of the different full-well-capacity (FWC) of pixels for a typical Gaia CCD. Some large differences are visible at the boundaries of the stitches used during CCD chip production. Note that the FWC will also vary with time.

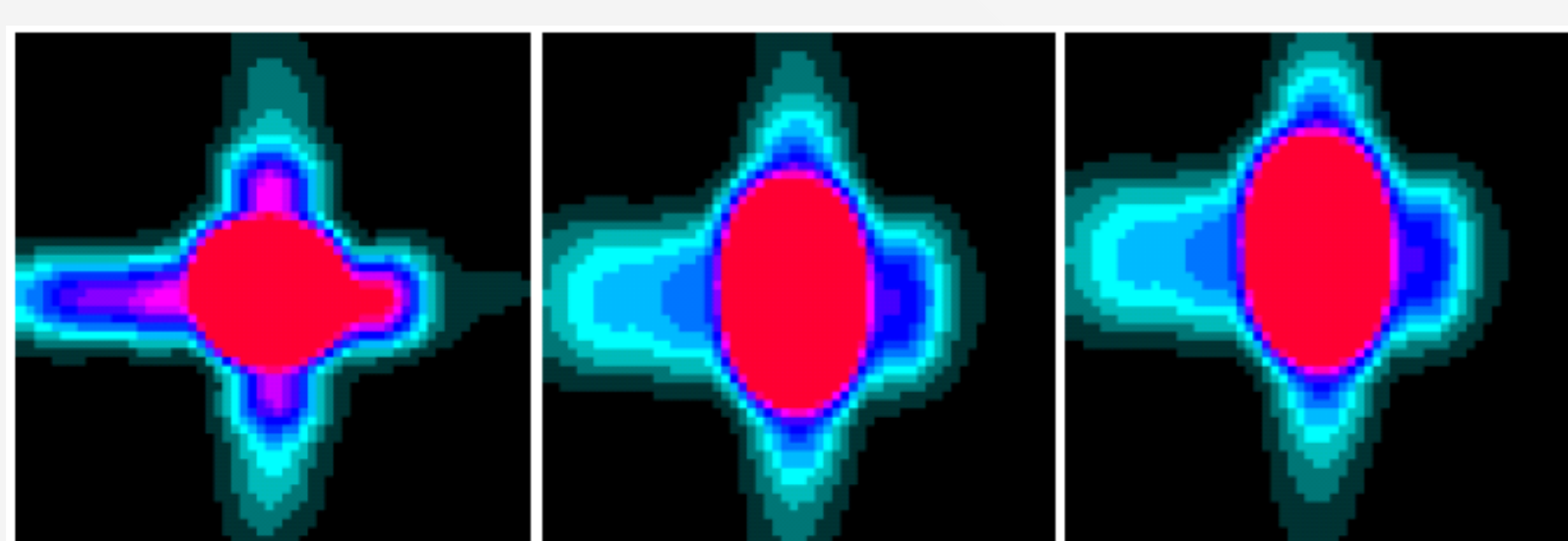
**Non-linearities:** A simple non-linearity effect can occur due to a wrong determination of the background signal. This will affect mainly faint sources. During the charge-to-voltage conversion and further on the analogue-digital chain non-linearity effects can be introduced on CCD-to-CCD level.

Earlier on during the charge transport some charge can be lost due to non-perfect CTE (Charge Transfer Efficiency). Transport is in along-scan direction in the image area, the summing register and across-scan in the read-out register.

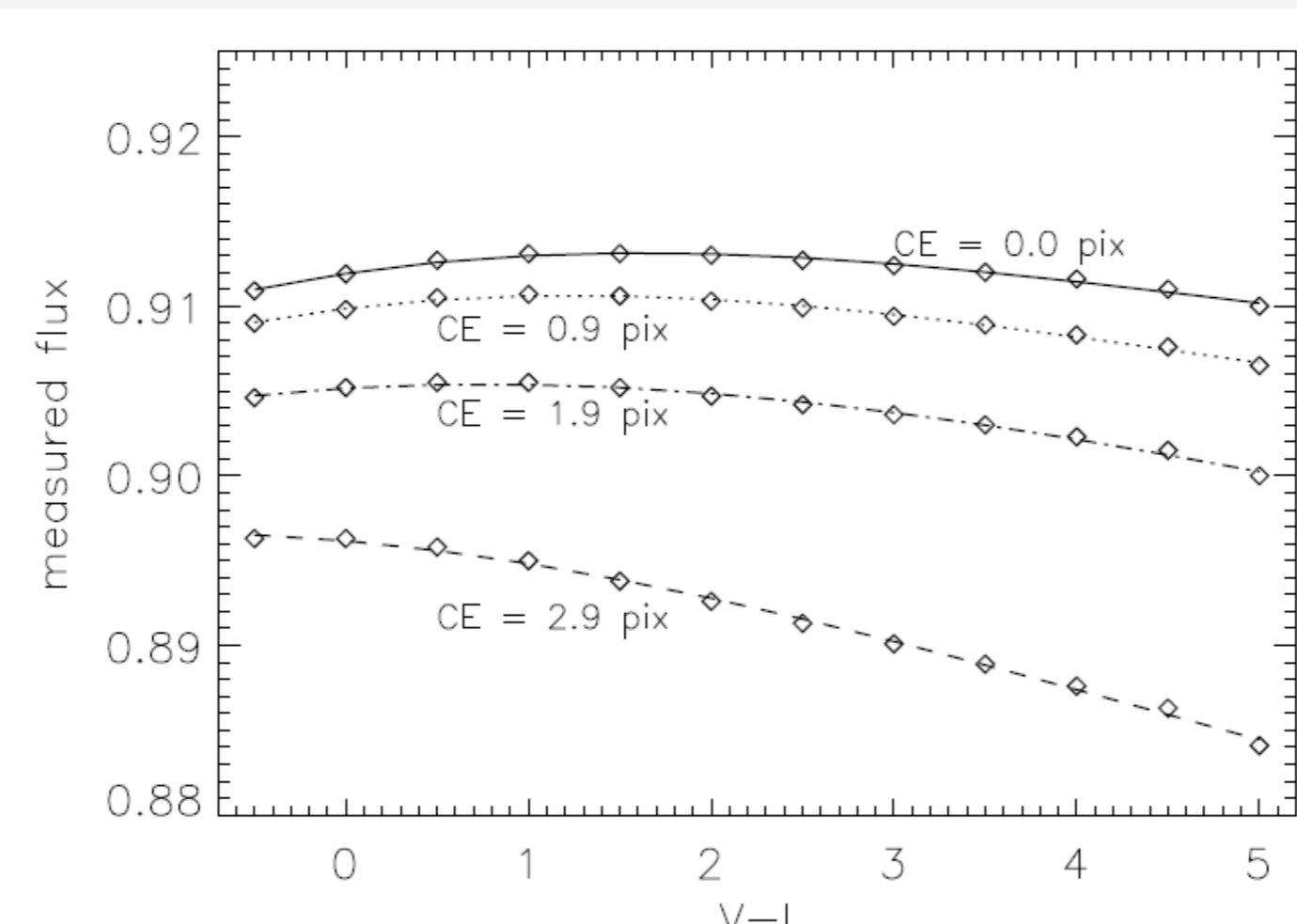
Some CTI effects will occur even in absence of radiation like the recently discovered effect in the serial register, some will occur during the mission triggered by radiation damage yielding to disturbed PSFs and additional flux loss. The along scan CTI effect will be mitigated by a periodic Charge Injection (CI) process filling up the  $e^-$  traps from time to time. Some residual CTI effects will remain depending on the history of transits, CI and radiation damage on pixel level. All yields of these CTI effects and its residuals have to be mitigated in the preprocessing of the data. Distorted PSFs/LSFs will be compared with predicted ones based on the information from the PSF/LSF model. Adjusting the model parameters by fitting the data allows to recreate a more or less undistorted signal. Due to uncertainties of the PSF/LSF model, noisiness of the data and computational restraints some residuals will be left to deal with the internal calibration. As the current knowledge about these effects is partially still limited and no qualitative information about the expected residuals is available yet only basic ideas about the mitigation strategy within the internal calibration are under consideration at the moment. These strategies will be a main part of our future work.

**Polarization:** Intensity variations up to 1% are expected for bright, extremely polarized sources. As these sources are very rare the effect can be analyzed in the final solutions only.

## Across-scan flux loss



PSFs (5 times oversampled) showing the different effects influencing the across-scan flux loss (from left to right): Well-centered PSF with no across scan motion, well-centered PSF with nominal (mean) across scan motion and PSF decentered by one Gaia pixel with nominal across scan motion. Note that the PSFs are also varying with the colour of the source and the position in the FoV.

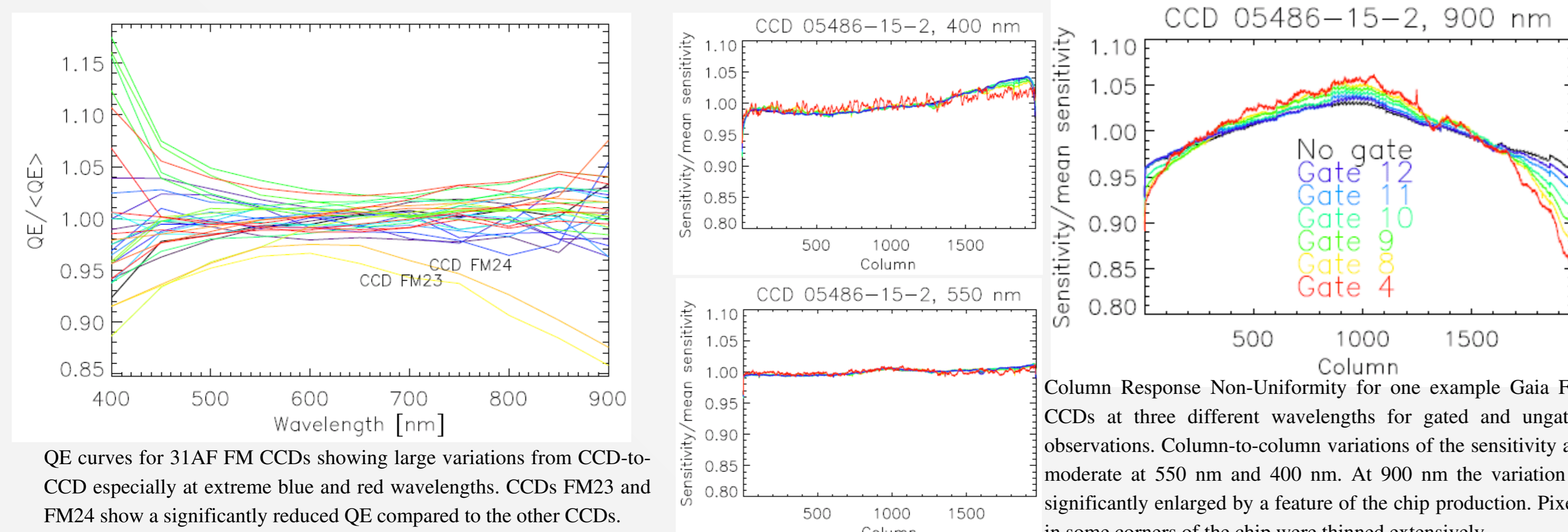


Dependency of the fraction of the measured G flux on the V-I colour of the source and the centering error (CE). Additionally this fraction depends on the scan motion of the satellite.

Due to the limited size of the extraction window not all light from the sources reaching the focal plane is converted into a measured signal. A fraction of about 10% of the signal is lost outside the window depending on the colour of the source, the centering error (CE) of the PSF within the window, the across scan motion of the satellite and the position of the source within the FoV. For 2D observations this flux loss can be corrected by fitting PSF/LSF fitting. For 1D observations ( $G < 13$ ) without recorded across component only the flux loss along scan can be estimated by LSF fitting.

The across-scan flux loss was analysed in dependence on source colour ( $-0.5 < V-I < 5.0$ ), CE ( $-2.9 < CE < +2.9$  pixel), across scan motion (zero to maximal) and position in the FoV using simulated PSFs for the centre of the CCD/FoV combinations. The variation of the flux loss with a range of up to 2.7% is significant and is accounted for in the internal calibration.

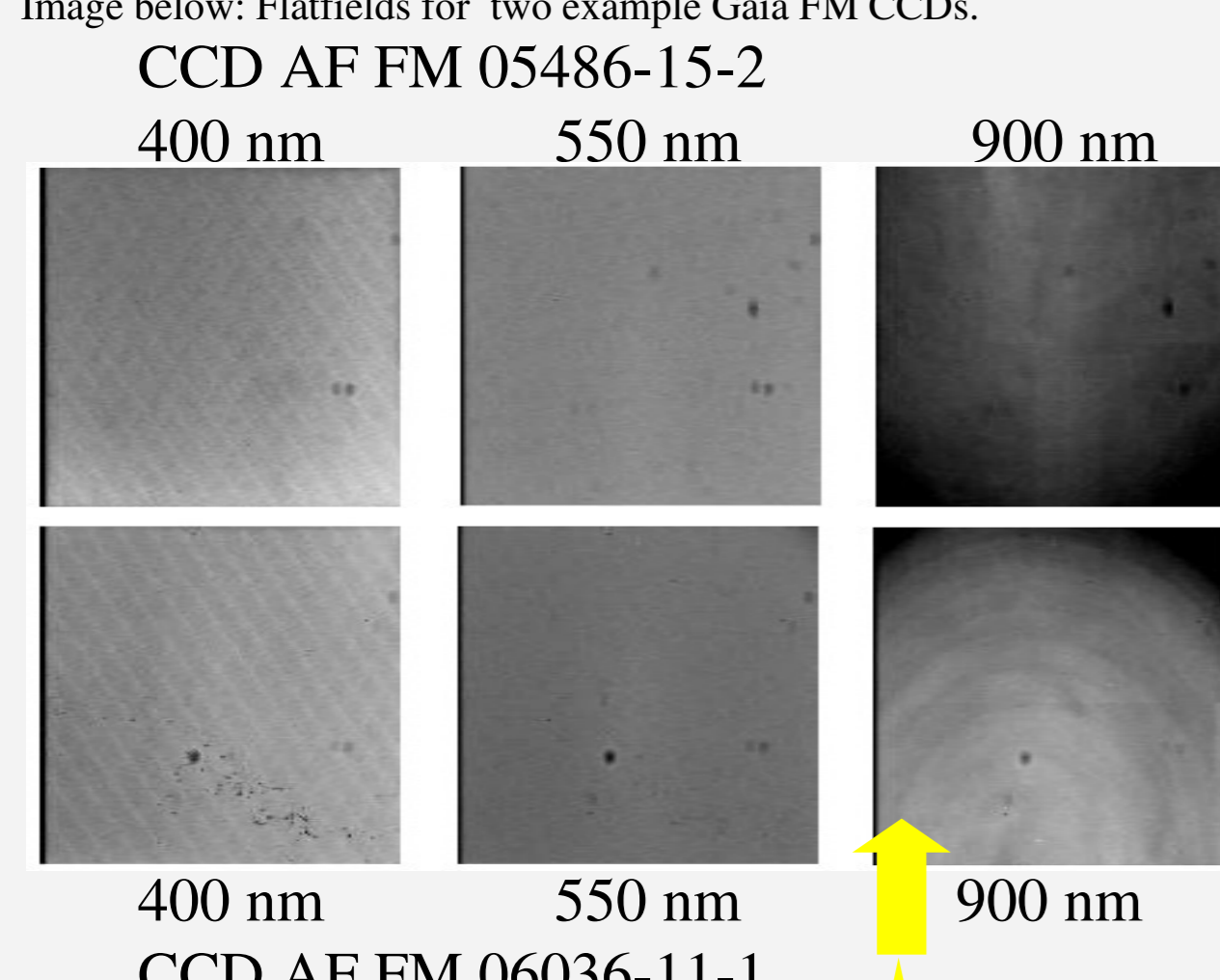
## Sensitivity variations



QE curves for 31AF FM CCDs showing large variations from CCD-to-CCD especially at extreme blue and red wavelengths. CCDs FM23 and FM24 show a significantly reduced QE compared to the other CCDs.

The sensitivity variations of the instrument are thought to be dominated by the variations of the CCDs. Extensive sensitivity variations from CCD-to-CCD were found especially at extreme red and blue wavelengths. Analysing flat field images from two typical AF FM CCDs revealed some systematic pattern originating from the annealing process during the donation procedure of the chips. As the Gaia CCDs will work in TDI mode the combined sensitivity of a full column (or parts of it for gated observations of bright sources) is relevant. Thus this systematic pattern is only important for observations with the shortest gates activated. At intermediate wavelengths the column-to-column sensitivity variations are small for gated and ungated observations. A feature of the Gaia AF CCD chips is that two corners and the corresponding edge are extensively thinned (corner effect). At red wavelengths (where the sensitivity directly scales with the pixel thickness; Ralf Kohley, private communication) this yields to a reduced sensitivity of up to 40% compared to the other areas of the CCD on the pixel level. On the column-to-column level this effect is smaller. Depending on the two possible orientations of the chip during the thinning process it affects more the short gated observation (variation across > 20%) or the ungated observations (variations across > 8%). This effect is thought to complicate especially the calibration of red sources which are rare in relative numbers and often variable.

Image below: Flatfields for two example Gaia FM CCDs.



The sensitivities of the CCDs, their columns and the entire instrument is also expected to vary with time mainly due to radiation damage on the pixel level. Based on information about other space missions (HST STIS & ACS, XMM OM) with comparable instrument units the effect is thought to be in an order or less than 1% per year of mission time. The effect will be wavelength-dependent, blue wavelengths are more affected than red wavelengths.

The reflectivity of the optical elements will decline moderately by out-gassing and contamination with dust particles originating from the outer-space environment.